

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09/805,586	LOTSPIH, JOHN ANTHONY
	Examiner Joseph F Edell	Art Unit 3636

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6056316	05-2000	Yamaji et al.	280/730.2
	C	US-6129377	10-2000	Okumura et al.	280/730.2
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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